Laboratory	Electronics Test and Development Centre, Housefed Complex, Central Block, 1st & 2nd Floor, Beltola-Basistha Road, Dispur, Guwahat Assam			
Accreditation Standard	ISO/IEC 17025:2005			
Discipline	Electro-Technical Calibration C-0024		Issue Date	20.11.2014 19.11.2016
Certificate Number			Valid Until	
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Quantity Measured / Instrument	Range/ Frequency *	Calibration Measurement Capability (±)	Remarks	
<u>SOURCE</u>				
1. DC VOLTAGE [#]	1 mV to 100 mV 100 mV to 1 V 1 V to 1000 V	0.073 % to 0.0010 % 0.0010 % to 0.0006 % 0.0006 % to 0.0010 %	Using Multifunction Calibrator Fluke 5520A/ 5720 A by Direct Method	
2. DC CURRENT [#]	100 µA to 2 A 2 A to 10 A 10 A to 20 A	0.012 % to 0.006 % 0.006 % to 0.05 % 0.05 % to 0.12 %	Using Guildline Discrete Resistances/ MFC Fluke 5720A/ 5520A by Direct Method	
3. DC RESISTANCE ^{\$}	$100 \ \mu\Omega$ $1 \ m \ \Omega \ to \ 1 \ \Omega$ $1 \ \Omega \ to \ 1 \ k\Omega$ $1 \ k\Omega \ to \ 100 \ M\Omega$ $100 \ M\Omega \ to \ 1 \ T\Omega$	0.011 % 0.001 % to 0.0006 % 0.0006 % to 0.0007 % 0.0007 % to 0.0025 % 0.0025 % to 0.2 %	Standar MFC 5720A	ldline 9334A d Resistor/ C Fluke A/ 5520A ct Method
DC RESISTANCE*	100 M Ω to 1 G Ω	1.5 % to 0.002 %		Fluke 5520A ct Method
4. AC VOLTAGE [#]	50 Hz to 20 kHz 10 mV to 100 mV 100 mV to 100V 100 V to 1000 V	0.06 % to 0.015 % 0.015 % to 0.008 % 0.008 % to 0.018 %		Fluke 5720A/ Direct Method
Vishal Shukla Convenor	_		Aviji Program	t Das Manager

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Acc	reditation Standard	ISO/IEC 17025:2005			
Disc	cipline			Issue Date	20.11.2014
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G	Quantity Measured / Instrument	Range/ Frequency * C	alibration Measurement Capability (±)	Remarks	
5.	AC CURRENT [#]	50 Hz to 1 kHz 100 μA to 200 mA 200 mA to 2 A 2 A to 10 A	0.04 % to 0.017 % 0.017 % to 0.03 % 0.03 % to 0.07 %		Fluke 5720A/ Direct Method
		50/60 Hz 10 A to 20 A	0.06 % to 0.17 %		
6.	FREQUENCY ^{\$}	10 Hz to 3 GHz	0.002 % to 0.00001 %	Ref Source/	ke 9640A RF R&S SMT-03 ct Method
	FREQUENCY*	10 kHz to 3 GHz	0.0003 %	Reference Fluke	xe 9640A RF Source/ MFC e 5520A ct Method
7.	INDUCTANCE#	1 kHz 0.1 mH to 11 H	0.1 % to 2.0 %	IET/ Decade	nductance 1482 Inductance Box Direct Method

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Quantity Measured / Instrument	Range/ Frequency	* Calibration Measurement Capability (±)	Remarks	
8. CAPACITANCE ^{\$}	1 kHz 10 pF to 100 pF 100 pF to 1 μF	0.24 % to 0.03 %	Capacitor 14 Capacitat	ef. Standard 08 IET/ Decade nce Box GR Direct Method
CAPACITANCE*	1 kHz 10 pf to 1.1 μF	0.06 %	Programma	Fluke 5520 ble Generator ct Method
9. 3 ф POWER/ ENERG	Y [#] 50 Hz 9 W to 45 kW 60 V to 300 V 0.05 A to 50 A 0.5 pF to UPF	0.015 % to 0.065 %	Using Rotek 8100/Zera Com 3003 Calibrators by Direct Method	
<u>MEASURE</u>				
1. DC VOLTAGE [#]	1 mV to 100 mV 100 mV to 10 V 10 V to 1000 V	0.015 % to 0.0010 % 0.0010 % to 0.0006 % 0.0006 % to 0.001 %	8508/Wa by Direct/	DMM Fluke wetek 1271 Comparison ethod

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Last Amended on					
Quantity Measured / Instrument	Range/ Frequency * Cali	bration Measurement Capability (±)	Remarks		
2. AC VOLTAGE [#]	50 Hz to 10 kHz 10 mV to 100 mV 100 mV to 1000 V	0.061 % to 0.015 % 0.015 % to 0.01 %	8508/Wa	DMM Fluke wetek 1271	
	10 kHz to 100 kHz 10 mV to 100 mV 100 mV to 100 V	0.3 % to 0.12 % 0.12 % to 0.091%	by Direct/Compariso Method		
3. DC CURRENT [#]	100 μA to 200 mA 200 mA to 2 A 2 A to 20 A	0.003 % to 0.0053 % 0.0053 % to 0.022 % 0.022 % to 0.05 %	Using 8 ½ DMM Fluke 8508/Wavetek 1271 by Direct/Comparison Method		
4. AC CURRENT [#]	50 Hz to 1 kHz 100 μA to 200 mA 200 mA to 2 A 2 A to 20 A	0.06 % to 0.05 % 0.05 % to 0.1 % 0.1 %	8508/Wa by Direct/	DMM Fluke wetek 1271 Comparison ethod	
5. DC RESISTANCE ^{\$}	100 μΩ to 1 Ω 1 Ω to 1 ΜΩ 1 ΜΩ to 100 ΜΩ 100 ΜΩ to 20 GΩ	0.011 % to 0.001 % 0.001 % to 0.002 % 0.002 % to 0.01 % 0.01 % to 0.1 %	6520 Ter Guild DMM Fl by Direct/	Bridge 6622 & a ohmmeter line/8 ½ uke 8508A Comparison ethod	

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Disc	ipline	Electro-Technical Calibration		Issue Date	20.11.2014 19.11.2016
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Q	Quantity Measured / Instrument	Range/ Frequency	* Calibration Measurement Capability (±)	Remarks	
	DC RESISTANCE*	100 μΩ to 20 GΩ	0.005 % to 1.0 %	by Direct/	MM Fluke 1271 Comparison ethod
6.	CAPACITANCE [#]	1 kHz 10 pF to 1 uF	0.2 % to 0.02 %	Using RLC Digibridge Quad Tech 1689 by Direct/Comparison Method	
7.	INDUCTANCE#	1 kHz 100 μH to 11 H	0.025 % to 0.25 %	Using RLC Digibridge Quad Tech 1689 by Direct/Comparison Method	
8.	FREQUENCY [#]	10 Hz to 3 GHz	0.001 % to 0.00001 %	Programa by Direct	uke 6680B ible Counter 'Comparison ethod

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Discipline	Electro-Technical Calibration Issue Date 20.11.2014					
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Quantity Measured / Instrument	Range/ Frequency	* Calibration Measurement Capability (±)	Rema	rks		
9. 3 4POWER / ENERGY [#]	50 Hz 9 W to 45 kW 60 V to 300 V 0.05 A to 50 A 0.5 pF to UPF	0.0250 %	MSB Com3003 by Direct/	otek 8100/ 100/Zera Calibrators Comparison ethod		

* Measurement Capability is expressed as an uncertainty (±) at a confidence probability of 95%

^{\$}Only in Permanent Laboratory

*Only for Site Calibration

[#]The laboratory is also capable for site calibration however, the uncertainty at site depends on the prevailing actual environmental conditions and master equipment used.